

# SN54ALS38B, SN74ALS38B QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS WITH OPEN-COLLECTOR OUTPUTS

SDAS196B - APRIL 1982 - REVISED DECEMBER 1994

- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

## description

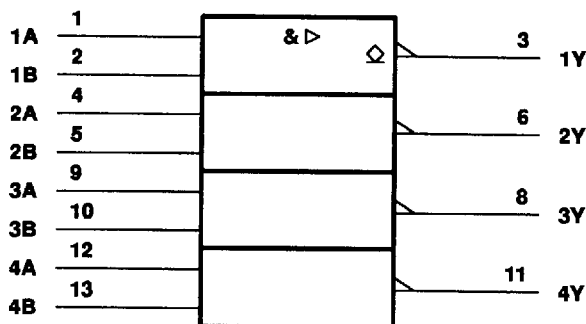
These devices contain four independent 2-input positive-NAND buffers with open-collector outputs. They perform the Boolean functions  $Y = \overline{A \cdot B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic. The open-collector outputs require pullup resistors to perform correctly. These outputs may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices often are used to generate higher  $V_{OH}$  levels.

The SN54ALS38B is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74ALS38B is characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

FUNCTION TABLE  
(each gate)

INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

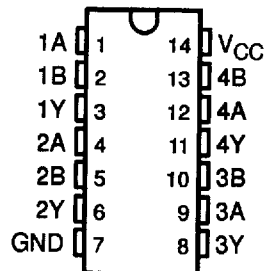
## logic symbol†



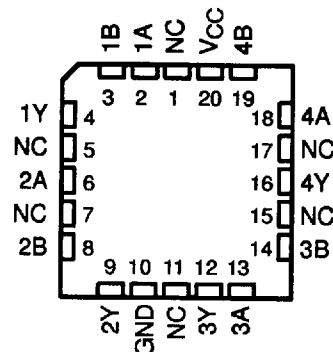
† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

SN54ALS38B ... J PACKAGE  
SN74ALS38B ... D OR N PACKAGE  
(TOP VIEW)

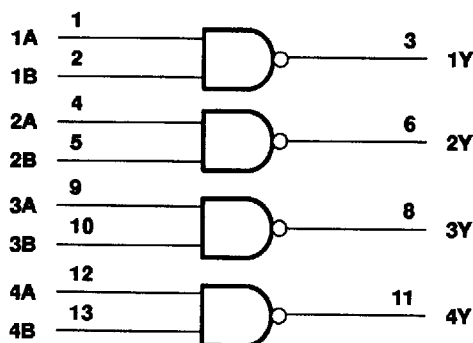


SN54ALS38B ... FK PACKAGE  
(TOP VIEW)



NC - No internal connection

## logic diagram (positive logic)



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, $V_{CC}$	7 V
Input voltage, $V_I$	7 V
Operating free-air temperature range, $T_A$ : SN54ALS38B	-55°C to 125°C
SN74ALS38B	0°C to 70°C
Storage temperature range	-65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## recommended operating conditions

	SN54ALS38B			SN74ALS38B			UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX			
$V_{CC}$ Supply voltage	4.5	5	5.5	4.5	5	5.5	V		
$V_{IH}$ High-level input voltage	2			2			V		
$V_{IL}$ Low-level input voltage	0.7			0.8			V		
$V_{OH}$ High-level output voltage	5.5			5.5			V		
$I_{OL}$ Low-level output current	12			24			mA		
$T_A$ Operating free-air temperature	-55			125			0	70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	SN54ALS38B			SN74ALS38B			UNIT
		MIN	TYP‡	MAX	MIN	TYP‡	MAX	
$V_{IK}$	$V_{CC} = 4.5 V$ , $I_I = -18 mA$	-1.5			-1.5			V
$V_{OL}$	$V_{CC} = 4.5 V$	$I_{OL} = 12 mA$			0.25 0.4			V
		$I_{OL} = 24 mA$			0.35 0.5			
$I_I$	$V_{CC} = 5.5 V$ , $V_I = 7 V$	0.1			0.1			mA
$I_{IH}$	$V_{CC} = 5.5 V$ , $V_I = 2.7 V$	20			20			$\mu A$
$I_{IL}$	$V_{CC} = 5.5 V$ , $V_I = 0.4 V$	-0.1			-0.1			mA
$I_{OH}$	$V_{CC} = 4.5 V$ , $V_{OH} = 5.5 V$	0.1			0.1			mA
$I_{CCH}$	$V_{CC} = 5.5 V$ , $V_I = 0$	0.86 1.6			0.86 1.6			mA
$I_{CCL}$	$V_{CC} = 5.5 V$ , $V_I = 4.5 V$	4.8 7.8			4.8 7.8			mA

‡ All typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^\circ C$ .

## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 V$ to $5.5 V$ , $C_L = 50 pF$ , $R_L = 500 \Omega$ , $T_A = MIN$ to $MAX$ §				UNIT
			SN54ALS38B		SN74ALS38B		
			MIN	MAX	MIN	MAX	
$t_{PLH}$	A or B	Y	7	59	10	33	ns
$t_{PHL}$			2	20	1	12	

§ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

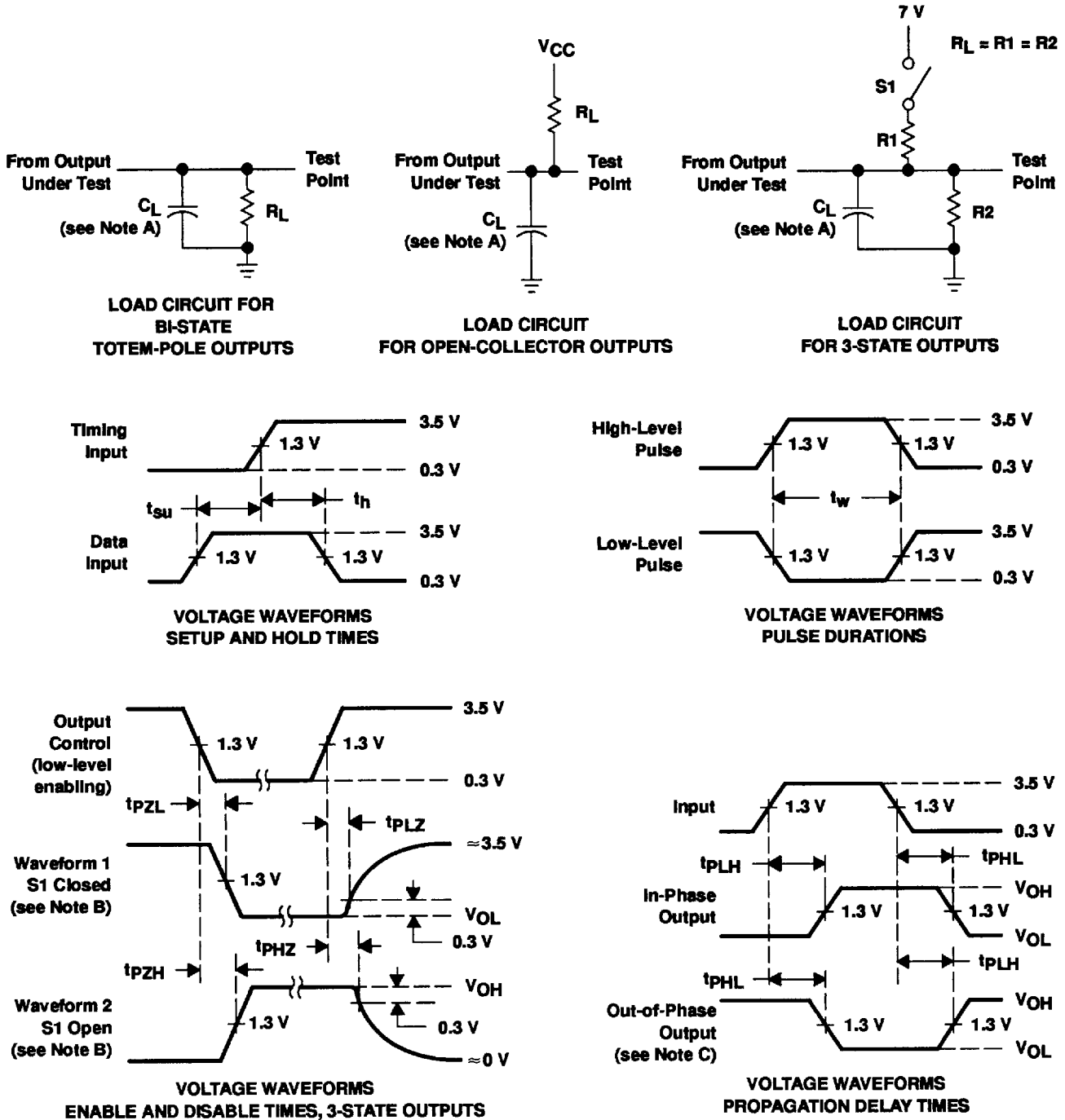


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## PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.  
 C. When measuring propagation delay items of 3-state outputs, switch  $S_1$  is open.  
 D. All input pulses have the following characteristics:  $PRR \leq 1$  MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.  
 E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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